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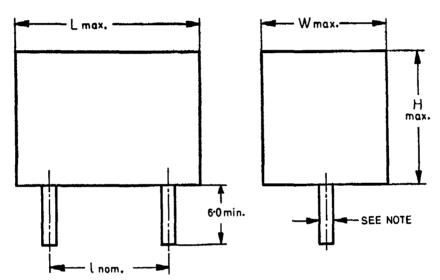
Indian Standard

SPECIFICATION FOR FIXED METALLISED POLYCARBONATE FILM DIFLECTRIC CAPACITORS

PART 3 TYPE FCCM2

1. Scope

- 1.1 This standard (Part 3) covers fixed metallised polycarbonate capacitors, rectangular (box type) non-hermitically sealed, insulated, plastic encased, moulded or epoxy filled, radial lead configuration.
- 1.2 This standard (Part 3) shall be read in conjunction with IS: 11515 (Part 1)-1985 'Specification for fixed metallized polycarbonate film dielectric capacitors: Part 1 General requirements and methods of tests'.
- 2. Outline, Drawing and Dimensions The outline drawing and dimensions shall be according to Fig. 1 and Table 1.



Typical construction: Non-hermetically sealed, plastic encased moulded or epoxy filled.

Note — Termination diameters are $0.80^{+0.08}_{-0.05}$ mm for all the case sizes.

FIG. 1 OUTLINE DRAWING AND DIMENSIONS

- 3. Ratings Ratings shall be as specified in Table 1.
- 4. Characteristics:

a) Selection tolerance

: ±2 percent, ±5 percent, ±10 percent, ±20 percent

b) Stability

: ±3 percent

c) Vibration

: 10-2 000 Hz, 200m/s²

d) Bump

: 4 000, 400 m/s²

e) Low air pressure

: 1 kPa

f) Climatic category

: 55/125/56

g) Temperature co-efficient

: $-200 \text{ ppm } \pm 250 \text{ ppm}$

- 5. Marking See 7 of IS; 11515 (Part 1)-1985.
- 6. Material, Construction and Workmanship See 5 of IS; 11515 (Part 1) 1985.

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Gr 3

Capaci- tance	i	63	V DC			100\	/ DC			250	V DC			400	V DC			630	V DC	
(μF)	L Max	l Nom	H Max	W Max	L Max	I Nom	H Max	W Məx	L Max	Nom	H Max	W Max	L Max	I Nom	H Max	W Max	L Max	I Nom	H Max	W Max
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)	(10)	(11)	(12)	(13)	(14)	(15)	(16)	(17)	(18)	(19)	(20)	(21)
0.001																	13	10.0	10 [.] 5	5.0
0.001 2			•														13	10.0	10.5	5.0
0.002 2																	13	10.0	10.5	5.0
0.003 3																	13	10.0	10 [.] 5	5.0
0.004 7																	13	10.0	10 [.] 5	5 0
0.006 8																	13	10 [.] 0	10.5	5.0
0.01													13	10.0	10 [.] 5	5.0	13	10.0	10.5	5.0
0.015													13	10 [.] 0	10 [.] 5	5.0	13	10.0	10 [.] 5	5.0
0 [.] 0 2 2									13	10 [.] 0	10 [.] 5	5.0	13	10 [.] 0	10·5	5.0	13	10 [.] 0	11 [.] 5	6.0
0 033									13	10.0	10.5	5.0	13	10.0	11.5	6.0	18	15 0	12 [.] 0	6.5
0 047									13	100	10.5	5.0	18	15 [.] 0	11.0	5.2	18	15 0	12.0	6.5
0.068					13	1 0 ·0	10 [.] 5	5.0	13	10 [.] 0	10 [.] 5	5.0	18	15.0	11.0	5.2	18	15 [.] 0	14.0	7.5
0.10	13	10 ⁻ 0	10 [.] 5	5.0	13	10 [.] 0	10 [.] 5	5 .0	18	15 [.] 0	11.0	5.2	18	15.0	12.0	6.5	27	22.2	15 [.] 5	6.5
0.15	13	10 [.] 0	10· 5	5.0	13	10·0	10 [.] 5	5 ·0	18	15.0	12.0	6· 5	18	15.0	14 [.] 0	7.5	27	22.5	18 [.] 5	8.5
0.22	13	10 [.] 0	10.5	5.0	13	10.0	11.5	6.0	18	15 0	13.0	7.0	27	22.5	15.5	6.5	27	2 2· 5	19·0	10 [.] 5
0.33	13	10 [.] 0	10.5	5.0	18	15.0	11.0	5.5	18	15 0	15.0	9.0	27	22.5	16 [.] 5	7.5	32	27.5	21.0	11.5
0 47	13	10 [.] 0	11.5	6.0	18	15 0	12 [.] 0	6.2	27	22 5	15.5	6.2	27	22 5	19.0	10 [.] 5	32	2 7·5	24.5	14.0
0.68	13	10.0	11:5	6.0	18	15 [.] 0	14 [.] 0	7.5	27	22 5	16·5	7.5	32	27 [.] 5	21.0	11.5				
1.0	18	15.0	11.0	5.2	18	15 ·0	15 [.] 0	9.0	27	22.5	19.0	9.5	32	27.5	24.5	14 [.] 0				
1.5	18	15 [.] 0	12.0	6.2	27	22.2	16· 5	7.5	32	27 [.] 5	24.5	11.5								
2.2	18	15 [.] 0	14.0	7.5	27	22 [.] 5	16.5	7.5	32	27.5	24.5	14.0								
3·3	27	22 [.] 5	16· 5	7:5	27	22·5	19 [.] 0	10 [.] 5												
4.7	27	22·5	18 5	8.5	32	27.5	21.0	11.5												
6 ·8	27	22.5	20.5	10.0	32	27.5	24 [.] 5	14.0												
0.0	32	27.5		11 [.] 5																

- 7. Classification of Tests See 8.1 of IS: 11515 (Part 1)-1985.
- 7.1 General Conditions for Test See 8.2 of IS: 11515 (Part 1)-1985.
- 7.2 Schedule of Type Tests The sequence of type tests and requirements shall be in accordance with Table 2.

	TABLE 2	TEST SCHEDULE AND REQUIREM	IENTS
SI No.	. Test	Clause Ref in IS : 11515 (Part 1)-1985	Requirement
(1)	(2)	(3)	(4)
I)	Group 0		
	a) Visual examination	8.4.1	The condition, workmanship and finish shall be satisfactory. Marking shall be legible.
	b) Dimensions	8.4.2	The dimensions of the capacitors and their terminations shall be in accordance with Table 1 and Fig. 1.
	c) Capacitance	8.3.2	The capacitance value shall correspond with the rated capacitance value taking into account the tolerance.
	d) Tangent of loss angle	8.3.3 Fre q uency 1 kH z	As in 8.3.3.2 of IS:11515 (Part 1)-1985
	e) Voltage proof	8.3.1	There shall be no breakdown, or flashover.
	f) Insulation resistance	8.3.4	As in 8.3.4.3 of IS: 11515 (Part 1)- 1985.
H)	Sub-Group 1A		
	a) Initial measurements 1) Capacitance 2) Tangent of loss angle		
		For CR > 1 μF : at 1 kHZ CR ≤ 1 μF : at 10 kHz	
	b) Robustness of terminations	8,4.3	
	1) Visual examination	8.4.1	There shall be no visible damage.
	c) Resistance to soldering heat	8.4.4.2 No predrying	
	1) Visual examination	8.4.1	There shall be no damage
	2) Capacitance	8,3.2	$\frac{\triangle C}{C} \leqslant 1$ percent for Grade 1
			2 percent for Grade 2 of value measured in (a) above.
	3) Tangent of Loss angle	8.3.3	Increage of Tan δ: ≪0 003 for CR≪1 μF Grade 1 ≪0 002 for CR>1 μF Grade 1 ≪0 005 for CR≪1 μF Grade 2 ≪0 003 for CR>1 μF Grade 2 Compared to tan δ measured in (a) above.
111)	Sub-Group 1B		
	a) Solderability	8.4,4.1	Good tinning as evidenced by free flowing of the solder with welting o the terminations.
	b) Initial measurements		
	1) Capacitance		
	2) Tangent of loss angle	For C _R ≥ 1 μF; at 1 kHz C _R ≤ 1 μF; at 10 kHz	
			(Continued

TABLE 2 TEST SCHEDULE AND REQUIREMENTS - (Contd)									
SI No.	Test	Clause Ref. in IS : 11515 (Part 1)-1985	Requirement						
(1)	(2)	(3)	(4)						
•	Rapid change of Temperature	8.5.3 θA = −55°C θB = +125°C No. of cycles 5 Duration 8=30 minutes							
d)	1) Visual examination Vibration	8.4.1 8.4.5 10—2 000 Hz 200m/s³ Duration — 6h	There shall be no visible damage						
е)	1) Visual examination Bump	8.4.1 8.4.6 Number of Bumps — 4 000 Acceleration — 400 m/s²	There shall be no visible damage						
	Visual examination Capacitance	8.4.1 8.3,2	There shall be no visible damage △C ≤ 2.5% for Grade 1 C						
	3) Tangent of loss angle	8.3.3	4% for Grade 2 of the values measured in (B) above. Increase of tan δ < 0.003 for CR < 1 μF Grade 1 < 0.002 for CR > 1 μF Grade 1 < 0.005 for CR < 1 μF Grade 2 < 0.003 for CR > 1 μF Grade 2 Compared to values measured in (b) above.						
	4) Insulation resistance	8.3.4	IR shall be >50% of values given in I(f).						
,	roup 1 Climatic Sequence 1) Dry heat	8.5.1 8.5.1.2 Temperature +125°C Duration 16 h							
	2) Damp heat cyclic first cycle 3) Cold	8,5,1.3 8,5,1.4 Temperature —55°C Duration 2 h							
	Low air pressure i) Visual examination	8.5.1,5 1 kpa 8,4.1	There shall be no permanent break down, flashover or harmful deformation of the case.						
	5) Damp heat cyclic (remaining cycles)	8,5.1.6							
b)	Final measurements 1) Visual examination	8.4.1	There shall be no visible damage. Marking shall be legible.						
	2) Capacitance	8.3,2	$\triangle C \le 3\%$ for Grade 1						
	3) Tangent of loss angle	8,3.3	\leqslant 5% for Grade 2 of the value measured in II (c) (2) or III(e)(2) as applicable. Increase of tan δ \leqslant 0.005 for CR \leqslant 1 μF Grade 1 \leqslant 0.008 for CR \leqslant 1 μF Grade 2 \leqslant 0.005 for CR $>$ 1 μF Grade 2						
	4) Insulation Resistance	8.3.4	compared to values measured in II(a) (1) or III(b) (1) as applicable IR shall be greater than 50 percent of the values given in I (f). (Continued)						

TABLE 2		TEST SCHEDULE AND REQUIREMEN	S - (Contd)				
SINo	. Test	Clause Ref in IS:11515(Part 1)-1985	Requirement				
(1)	(2)	(3)	(4)				
٧)	Group 2						
	 a) Damp heat (steady state) i) Initial measurements 	8.5.2					
	1) Capacitance2) Tangent of loss angle	8.3.2 At 1 kHz					
	ii) Final measurements	9.4.1	There shall be an exhibit design				
	1) Visual examination	8.4.1 8.3,2	There shall be no visible damage. The marking shall be legible. $\triangle C \le 3$ percent for Grade 1				
	2) Capacitance	0,0,2	C ≤ 5 percent for Grade 2				
			of the value measured in a(1) above				
	3) Tangent of loss angle	8,3,3	Increase of tan δ: ≤ 0.005 compared to the values measured in a(i) above				
	4) Insulation resistance	8.3.4	IR shall be \leq 50 percent of the values given in I(f).				
VI)	Group 3						
	a) Endurance	8.6 Decation					
		Duration Grade 1 2 000 h Grade 2 1 000 h					
	i) Initial measurements	0.2.2					
	Capacitance Tangent of loss angle	8.3.2 For CR > 1 μF at 1 kHz					
	, ,	For CR ≤ 1 μF at 10 kHz					
	ii) Final measurements 1) Visual examination	8,4,1	There shall be no visible damage.				
	•	•	The marking shall be legible.				
	2) Capacitance	8.3.2	∆C ≤ 3 percent for Grade 1 C C C C				
			5 percent for Grade 2 of the values measured in a(i) above.				
	3) Tangent of loss angle	8,3,3	Increase of tan δ : \leq 0'003 for C _R \leq 1 μ F Grade 1 \leq 0'002 for C _R $>$ 1 μ F Grade 1				
			0.005 for C _R ≤ 1 μF Grade 2				
			≤ 0.003 for C _R > 1 μF Grade 2 compared in values measured in a(i)				
		924	above.				
	4) Insulation resistance	8.3.4	IR shall be $>$ 50 percent of values in $I(f)$.				
VII)	Group 4 a) Characteristics depending on	temperature 8.3.6					
	1) Capacitance	8,3,2	As in 8.3.6 of IS: 11515 (Part 1)-1985				
	Insulation resistance (Grade 1 only)	8.3.4	As in 8.3.6 of IS: 11515 (Part 1)-1985				
	b) Charge and dischargei) Initial measurements						
	1) Capacitance	C _{R>} 1 μF at 1 kHz					
	2) Tangent of loss angle	C _R ≤ 1 μF at 10 kHz					
	ii) Final measurements						
	1) Capacitance	8,3,2	△C ≤ 2 percent for Grade 1				
	2) Tangent of loss angle	8,3,3	Increase of tan δ : \leq 0.003 for Cn \leq 1 μ F Grade 1				
			\leq 0 002 for C _R \geq 1 μ F Grade 1				
			 ≤ 0 005 for CR ≤ 1 µF Grade 2 ≤ 0 003 for CR > 1 µF Grade 2 				
			Compared to values measured in (b) (i) above.				
	3) Insulation Resistance	8.3.4	IR shall be > 50 percent of the values in I(f).				